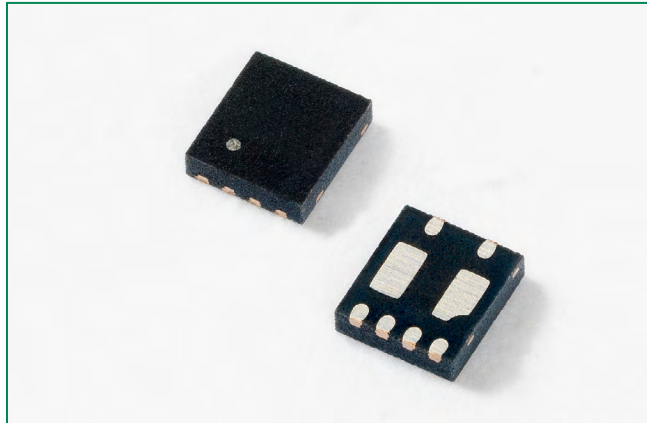


**SP1255P Series 0.5pF, 12kV Diode Array for  $\mu$ USB**



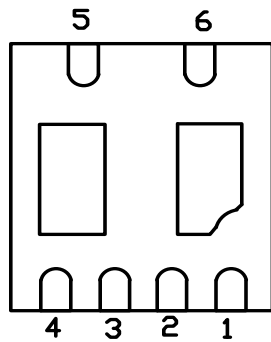
**Description**

The SP1255P integrates 3 channels of ultra-low capacitance steering diodes and a low voltage TVS diode to provide maximum protection of the USB data and ID pins against ESD per the IEC61000-4-2 standard. An additional 12V TVS diode is included to provide lightning surge protection for the USB  $V_{BUS}$  pin up to 100A ( $t_p=8/20\mu s$ ) per the IEC61000-4-5 standard. The SP1255P provides superior protection for current intensive applications such as fast charging peripherals.

The SP1255P comes in a space saving 2.0x1.8mm  $\mu$ DFN package with a typical height of 0.55mm making it an ideal solution for smart phones, tablets, and other portable electronics.

**Pinout**

AEC-Q101 qualified



Bottom View

**Features**

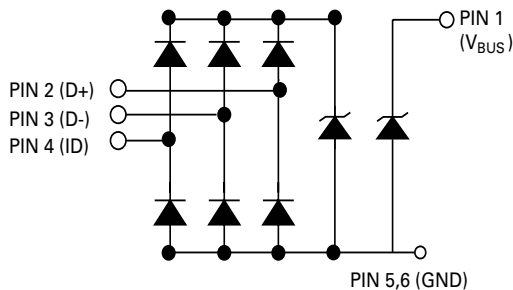
For USB Voltage Bus Pin ( $V_{BUS}$ )

- ESD, IEC61000-4-2,  $\pm 30kV$  contact,  $\pm 30kV$  air
- EFT, IEC61000-4-4, 80A ( $t_p=5/50ns$ )
- Lightning, IEC61000-4-5, 100A ( $t_p=8/20\mu s$ )
- Protection for  $V_{BUS}$  operating up to 12V
- Benchmark setting protection
- High current handling capability for fast charging applications

For USB Data Pin (D+, D-, ID)

- ESD, IEC61000-4-2,  $\pm 12kV$  contact,  $\pm 15kV$  air
- EFT, IEC61000-4-4, 40A ( $t_p=5/50ns$ )
- Lightning, IEC61000-4-5, 4A ( $t_p=8/20\mu s$ )
- 0.5pF capacitance
- Low clamping voltage and dynamic resistance ( $0.3\Omega$ )

**Functional Block Diagram**



**Applications**

- USB 2.0
- USB OTG
- $\mu$ USB
- Protection for the  $V_{BUS}$  circuit on USB2.0 Fast Charging

Life Support Note:

**Not Intended for Use in Life Support or Life Saving Applications**

The products shown herein are not designed for use in life sustaining or life saving applications unless otherwise expressly indicated.

### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$I_{PP}$ (Pin 1)	Peak Current ( $t_p=8/20\mu s$ )	100	A
$I_{PP}$ (Pin 2-4)	Peak Current ( $t_p=8/20\mu s$ )	4	A
$T_{OP}$	Operating Temperature	-40 to 125	°C
$T_{STOR}$	Storage Temperature	-55 to 150	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

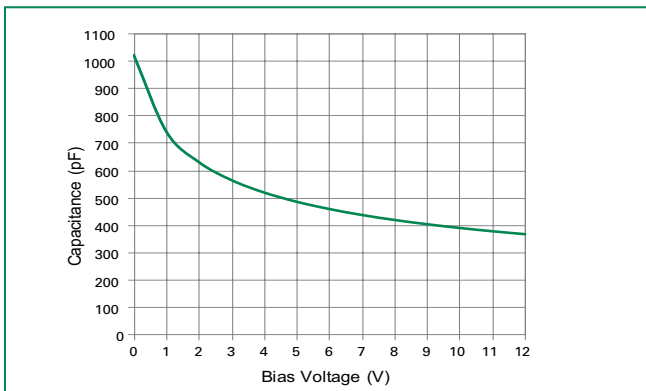
### Electrical Characteristics ( $T_{OP}=25^\circ C$ )

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
USB $V_{BUS}$ (Pin 1)						
Reverse Standoff Voltage	$V_{RWM}$	Pin 1 to GND			12	V
Reverse Breakdown Voltage	$V_{BR}$	$I_T=1mA$ , Pin 1 to GND	13.0	13.5	16.5	V
Reverse Leakage Current	$I_{LEAK}$	$V_R=12V$ , Pin 1 to GND			0.1	$\mu A$
Forward Voltage	$V_F$	$I_F=10mA$ , GND to Pin 1	0.6	0.7	1.0	V
Clamp Voltage <sup>1</sup>	$V_C$	$I_{PP}=30A$ , $t_p=8/20\mu s$ , Fwd		16.5	18	V
		$I_{PP}=100A$ , $t_p=8/20\mu s$ , Fwd		19.5	25	V
ESD Withstand Voltage <sup>1</sup>	$V_{ESD}$	IEC61000-4-2 (Contact)	$\pm 30$			kV
		IEC61000-4-2 (Air)	$\pm 30$			kV
Diode Capacitance <sup>1</sup>	$C_D$	Reverse Bias=0V, f=1MHz		1300	2500	pF
USB D+, D-, ID (Pin 2, 3, 4)						
Reverse Standoff Voltage	$V_{RWM}$	Pin 2, 3 and 4 to GND			4	V
Reverse Breakdown Voltage	$V_{BR}$	$I_T=2\mu A$ , Pin 2, 3 and 4 to GND	4.5	6.0	7.5	V
Reverse Leakage Current	$I_{LEAK}$	$V_R=2V$ , Pin 2, 3 and 4 to GND			0.02	$\mu A$
		$V_R=4V$ , Pin 2, 3 and 4 to GND			0.1	
Clamp Voltage <sup>1</sup>	$V_C$	$I_{PP}=1A$ , $t_p=8/20\mu s$ , Fwd		6.6	8.0	V
		$I_{PP}=2A$ , $t_p=8/20\mu s$ , Fwd		7.0	8.5	V
Dynamic Resistance	$R_{DYN}$	TLP, $t_p=100ns$ , Pin 2, 3 and 4 to GND <sup>2</sup>		0.3		$\Omega$
ESD Withstand Voltage <sup>1</sup>	$V_{ESD}$	IEC61000-4-2 (Contact)	$\pm 12$			kV
		IEC61000-4-2 (Air)	$\pm 15$			kV
Diode Capacitance <sup>1</sup>	$C_{WO-GND}$	Reverse Bias=0V, f=1MHz		0.5	0.6	pF

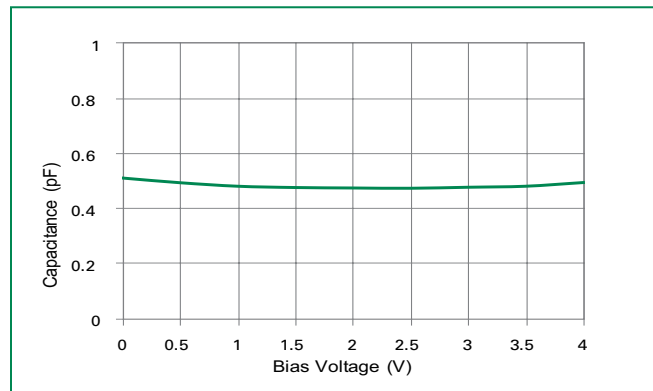
Note: 1 Parameter is guaranteed by design and/or device characterization.

2 Transmission Line Pulse (TLP) Test Setting:  $t_p=100ns$ ,  $t_r=0.2ns$   $I_{TLP}$  and  $V_{TLP}$ , averaging window: star  $t_1=70ns$  to  $t_2=90ns$

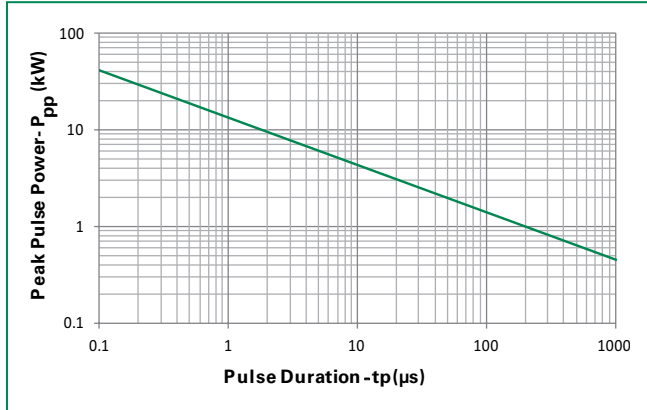
### Capacitance vs. Reverse Bias (Pin1 to GND)



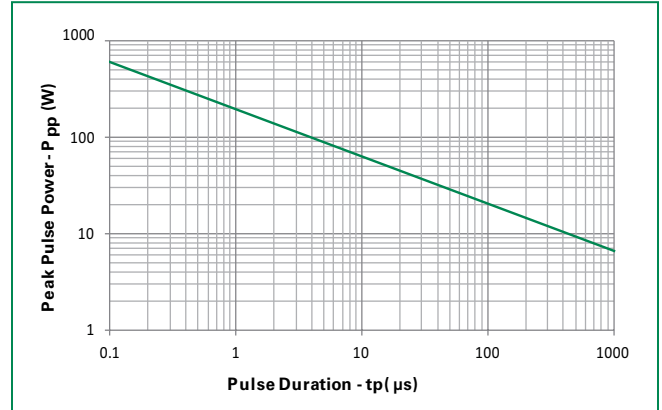
### Capacitance vs. Reverse Bias (Pin2, 3, 4 to GND)



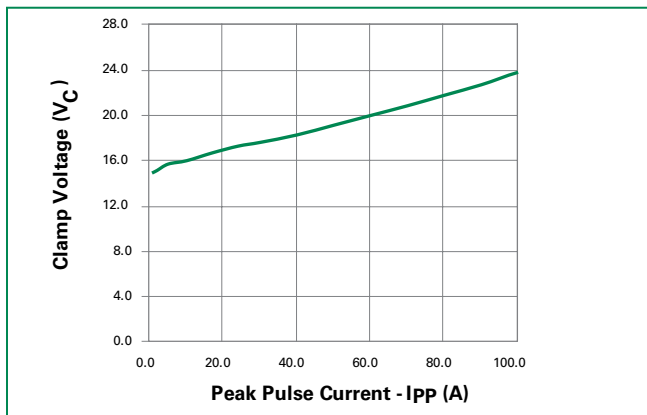
**Non-Repetitive Peak Pulse Power vs. Pulse Duration (Pin1 to GND)**



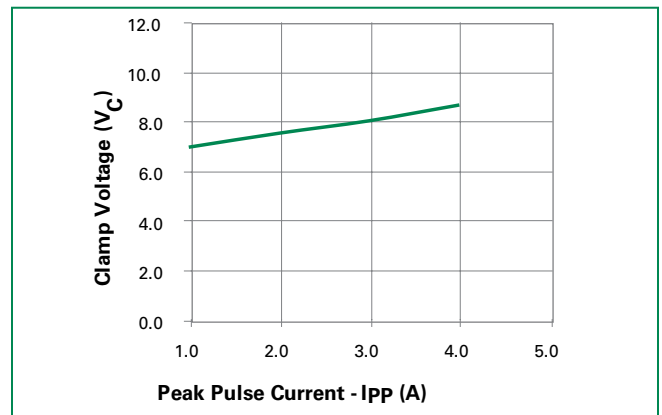
**Non-Repetitive Peak Pulse Power vs. Pulse Duration (Pin2, 3, 4 to GND)**



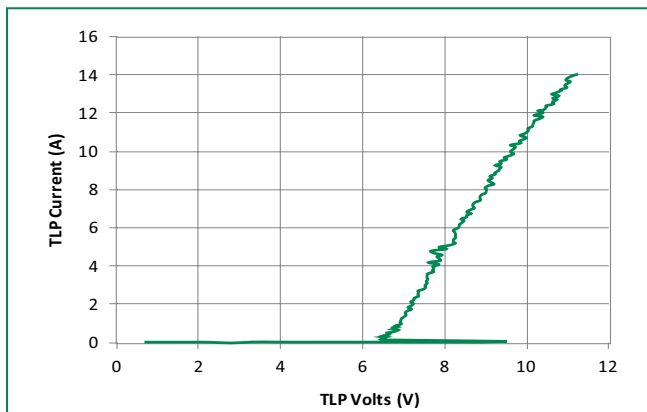
**Clamping Voltage vs. Peak Pulse Current (Pin1 to GND)**



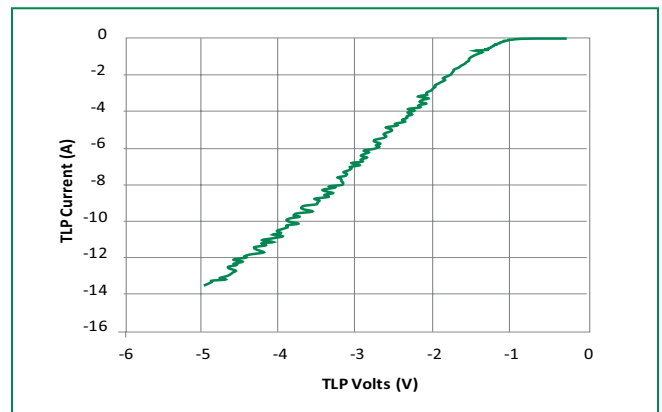
**Clamping Voltage vs. Peak Pulse Current (Pin2, 3, 4 to GND)**



**Positive Transmission Line Pulsing (TLP) Plot (Pin 2, 3, 4 to GND)**

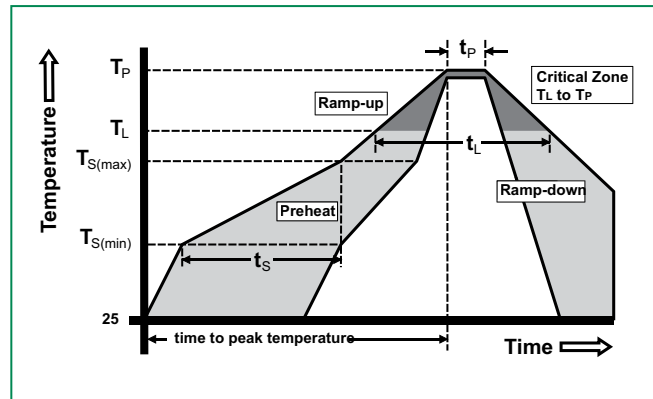


**Negative Transmission Line Pulsing (TLP) Plot (Pin 2, 3, 4 to GND)**

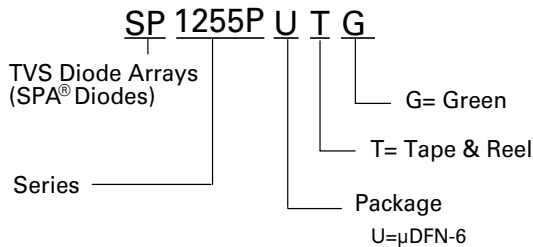


### Soldering Parameters

Reflow Condition		Pb – Free assembly
Pre Heat	- Temperature Min ( $T_{s(min)}$ )	150°C
	- Temperature Max ( $T_{s(max)}$ )	200°C
	- Time (min to max) ( $t_s$ )	60 – 180 secs
Average ramp up rate (Liquidus) Temp ( $T_L$ ) to peak		3°C/second max
$T_{s(max)}$ to $T_L$ - Ramp-up Rate		3°C/second max
Reflow	- Temperature ( $T_L$ ) (Liquidus)	217°C
	- Temperature ( $t_L$ )	60 – 150 seconds
Peak Temperature ( $T_p$ )		260 <sup>+0/-5</sup> °C
Time within 5°C of actual peak Temperature ( $t_p$ )		20 – 40 seconds
Ramp-down Rate		6°C/second max
Time 25°C to peak Temperature ( $T_p$ )		8 minutes Max.
Do not exceed		260°C



### Part Numbering System



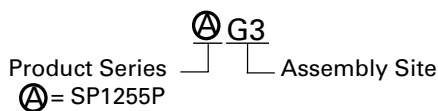
### Product Characteristics

<b>Lead Plating</b>	Pre-Plated Frame
<b>Lead Material</b>	Copper Alloy
<b>Lead Coplanarity</b>	0.0004 inches (0.102mm)
<b>Substrate material</b>	Silicon
<b>Body Material</b>	Molded Epoxy
<b>Flammability</b>	UL 94 V-0

Notes :

1. All dimensions are in millimeters
2. Dimensions include solder plating.
3. Dimensions are exclusive of mold flash & metal burr.
4. Blo is facing up for mold and facing down for trim/form, i.e. reverse trim/form.
5. Package surface matte finish VDI 11-13.

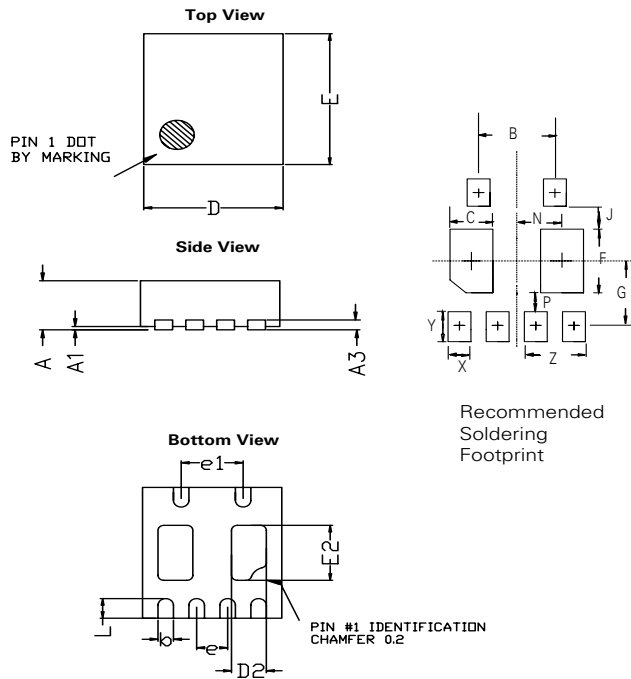
### Part Marking System



### Ordering Information

Part Number	Package	Marking	Min. Order Qty.	Packaging Option	P0/P1	Packaging Specification
SP1255PUTG	μDFN-6	ⒶG3	3000	Tape & Reel – 8mm tape/7" reel	2mm/4mm	EIA RS-481

**Package Dimensions —  $\mu$ DFN-6 (1.8x2.0x0.55mm)**

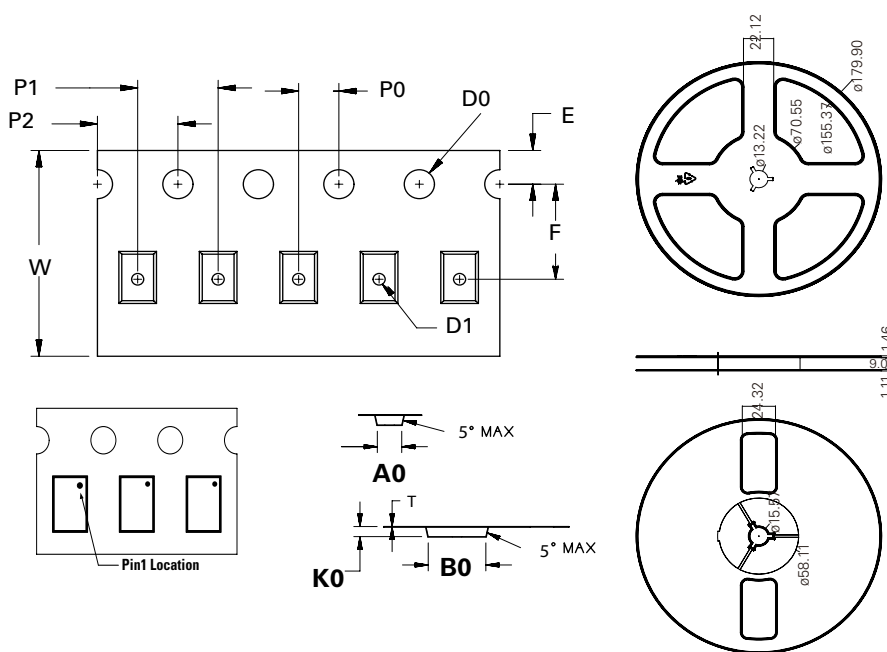


$\mu$ DFN6 (1.8x2.0x0.55mm)						
JEDEC MO-229						
Symbol	Millimeters			Inches		
	Min	Nom	Max	Min	Nom	Max
A	0.50	0.55	0.60	0.020	0.022	0.024
A1	0.00	-	0.05	0.000	-	0.002
A3	0.15 Ref			0.006 Ref		
D	1.75	1.80	1.85	0.069	0.071	0.073
E	1.95	2.00	2.05	0.077	0.079	0.081
b	0.15	0.20	0.25	0.006	0.008	0.010
L	0.20	0.30	0.40	0.008	0.012	0.016
D2	0.35	0.45	0.55	0.014	0.018	0.022
E2	0.74	0.84	0.94	0.029	0.033	0.037
e	0.40 BSC			0.016 BSC		
e1	0.80 BSC			0.031 BSC		
B	0.80 BSC			0.031 BSC		
C	0.35	0.45	0.55	0.014	0.018	0.022
F	0.81	0.84	0.87	0.032	0.033	0.034
G	0.82	0.85	0.88	0.032	0.033	0.034
J	0.24	0.25	0.26	0.010	0.010	0.010
N	0.47	0.48	0.49	0.018	0.019	0.020
P	0.24	0.25	0.26	0.010	0.010	0.010
X	0.23	0.24	0.25	0.009	0.009	0.009
Y	0.35	0.36	0.37	0.014	0.014	0.014
Z	0.62	0.64	0.66	0.024	0.025	0.026

Notes:

1. Dimension and tolerancing conform to ASME Y14.5M-1994.
2. Controlling dimensions: Millimeter. Converted Inch dimensions are not necessarily exact.

**Embossed Carrier Tape & Reel Specification —  $\mu$ DFN-6**



Symbol	Millimeters
A0	1.95 +/- 0.05
B0	2.30 +/- 0.05
D0	1.50 + 0.10
D1	Ø 0.60 + 0.05
E	1.75 +/- 0.10
F	3.50 +/- 0.05
K0	0.75 +/- 0.05
P0	2.00 +/- 0.05
P1	4.00 +/- 0.10
P2	4.00 +/- 0.10
T	0.25 +/- 0.02
W	8.00 + 0.30 /- 0.10